

**Notice of References Cited**

Application/Control No.

10/750,426

Applicant(s)/Patent Under  
Reexamination  
RANADE ET AL.

Examiner

DJENANE M. BAYARD

Art Unit

2441

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0018692	08-2001	Suginoshita et al.	707/204
*	B	US-2005/0114431	05-2005	Singh et al.	709/201
*	C	US-2002/0174126	11-2002	Britton et al.	707/100
*	D	US-6,954,765	10-2005	Spiegel, Christopher J.	707/200
*	E	US-2002/0087797	07-2002	Adrangi, Farid	711/133
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
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	X					

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